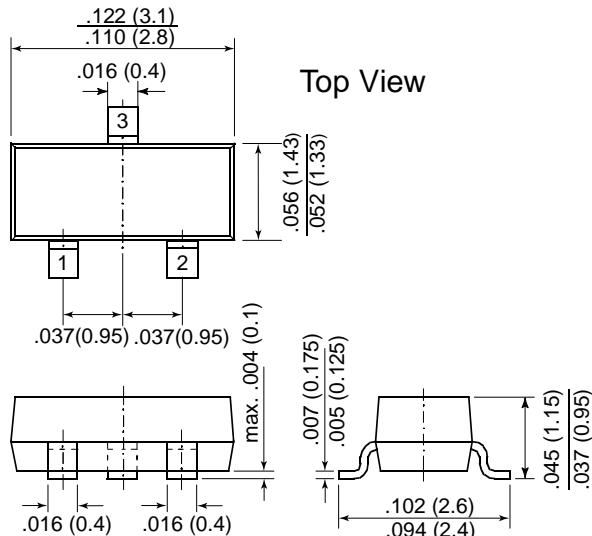
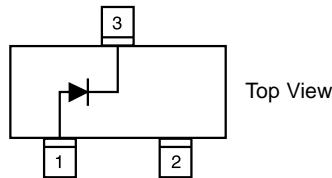



TO-236AB (SOT-23)

Dimensions in inches and (millimeters)
Marking
 BAS19 = A8
 BAS20 = A81
 BAS21 = A82


Features

- Silicon Epitaxial Planar Diode
- Fast switching diode in case SOT-23, especially suited for automatic insertion.
- These diodes are also available in other case styles including: the SOD-123 case with the type designations BAV19W to BAV21W, the Mini-MELF case with the type designation BAV101 to BAV103, the DO-35 case with the type designations BAV19 to BAV21 and the SOD-323 case with type designation BAV19WS to BAV21WS.

Mechanical Data

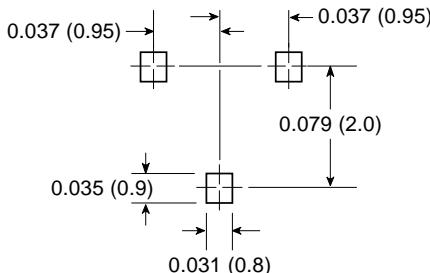
Case: SOT-23 Plastic Package

Weight: approx. 0.008g

Packaging Codes/Options:

 E8/10K per 13" reel (8mm tape), 30K/box
 E9/3K per 7" reel (8mm tape), 30K/box

Mounting Pad Layout



Maximum Ratings and Thermal Characteristics

(TA = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit
Continuous Reverse Voltage	BAS19	VR	100	V
	BAS20		150	
	BAS21		200	
Repetitive Peak Reverse Voltage	BAS19	V _{R_{RM}}	120	V
	BAS20		200	
	BAS21		250	
Non-Repetitive Peak Forward Current	at t = 1μs	I _{FSM}	2.5	A
	at t = 1s		0.5	
Average Rectified Forward Current (av. over any 20ms period)		I _{F(AV)}	200 ⁽¹⁾	mA
Forward DC Current at T _{amb} = 25°C		I _F	200 ⁽²⁾	mA
Repetitive Peak Forward Current		I _{FRM}	625	mA
Power Dissipation up to T _{amb} = 25°C		P _{tot}	250 ⁽²⁾	mW
Thermal Resistance Junction to Ambient Air		R _{θJA}	430 ⁽²⁾	°C/W
Junction Temperature		T _j	150	°C
Storage Temperature Range		T _s	-65 to +150	°C

 Notes: (1) Measured under pulse conditions; Pulse time = t_p ≤ 0.3ms

(2) Device on fiberglass substrate, see layout on next page

Electrical Characteristics

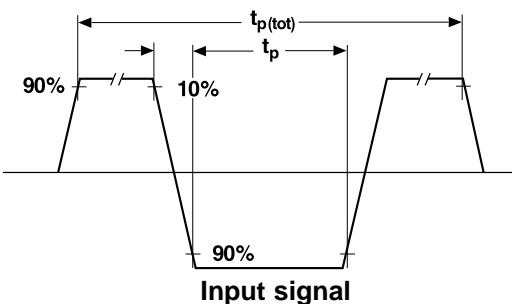
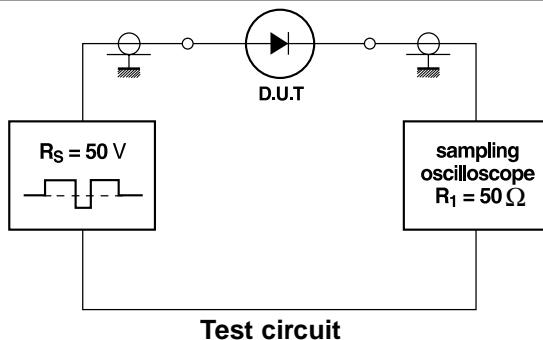
($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Forward Voltage	V_F	$I_F = 100\text{mA}$ $I_F = 200\text{mA}$	—	—	1.0 1.25	mV mV
Leakage Current	I_R	$V_R = V_{R\text{max}}$ $V_R = V_{R\text{max}}; T_J = 150^\circ\text{C}$	— —	— —	100 100	nA μA
Dynamic Forward Resistance	r_F	$I_F = 10\text{mA}$	—	5	—	Ω
Capacitance	C_{tot}	$V_R = 0$ $f = 1\text{MHz}$	—	—	5	pF
Reverse Recovery Time (see figures)	t_{rr}	$I_F = 30\text{mA}, I_R = 30\text{mA}$ $I_{rr} = 3\text{mA}, R_L = 100\Omega$	—	—	50	ns

(1)Device on fiberglass substrate, see layout (SOT-23).

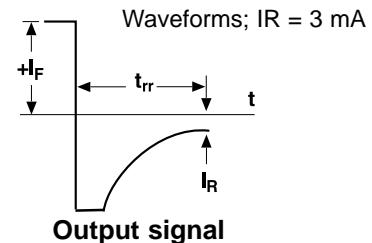
Test Circuit and Waveforms

(BAS19, BAS20, BAS21)



Input Signal	- total pulse duration - duty factor - rise time of reverse pulse - reverse pulse duration	$t_{p(\text{tot})} = 2\mu\text{s}$ $\delta = 0.0025$ $t_r = 0.6\text{ns}$ $t_p = 100\text{ns}$
Oscilloscope	- rise time - circuit capacitance*	$t_r = 0.35\text{ns}$ $C < 1\text{pF}$

*C = oscilloscope input capacitance + parasitic capacitance



Layout for $R_{\Theta JA}$ test

Thickness: Fiberglass 0.059 in. (1.5 mm)
Copper leads 0.012 in. (0.3 mm)

